

Notice of References Cited	Application/Control No. 10/540,736	Applicant(s)/Patent Under Reexamination TOMII, KENTARO	
	Examiner Elias Desta	Art Unit 2857	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Kubitscheck et al., 'Three-Dimensional Diffusion Measurements by Scanning Microphotolysis', November 1988, JOM, Vol. 192, Pt. 2, pages 126-138
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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